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	Filing Date		2000-01-21
	First Named Inventor	David A. Cathey	
	Art Unit	2879	
	Examiner Name	A. Patel	
	Attorney Docket Number	2269-7129.2US(95-0582.02/	

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/ AP/	5	Evtukh, et al. "Parameters of the Tip Arrays Covered by Low Work Function Layers," J. Vac. Sci Tech. B 14 (3), pp. 2130-2134, (Pub. May-June 1996).	<input type="checkbox"/>
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